



DEC 22 2003 FORM PTO-1449 LIST OF DOCUMENTS CITED BY APPLICANT				Atty. Docket No. A-9895	Appln. No. 10/614,826		
				Applicant Masashi DENDO			
				Filing Date July 9, 2003	Group 3679		
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
F	AA	5,593,262	01/14/97	Gedeon et al.	411	182	
	AB	4,971,500	11/20/90	Benoit et al.	411	182	
	AC	2,836,214	07/31/53	Rapata	411	182	
Fs	AD	4,077,300	03/07/78	Yoda	85	80	
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
Fs	AL	2 069 089	08/19/81	United Kingdom			
	AM						
	AN						
	AO						
	AP						
	AQ						
	AR						
	AS						
OTHER (including author, title, date, pertinent pages, etc.)							
	AT						
Examiner <i>F. Sæther</i>				Date Considered <i>G-28-04</i>			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							

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<u>LIST OF DOCUMENTS CITED BY APPLICANT</u>			A-9895				
			Applicant				
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			Filing Date	Group			
			HEREWITH				
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
<b>FOREIGN PATENT DOCUMENTS</b>							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
<i>FS</i>	AJ	49-25957	3/5/74	Japan			no
<i>FS</i>	AK	55-124618	9/4/80	Japan			no
<i>FS</i>	AL	7-10527	2/14/95	Japan			no
	AM						
	AN						
	AO						
<b>OTHER</b> (including author, title, date, pertinent pages, etc.)							
	AP						
	AQ						
	AR						
Examiner <i>F. Soother</i>				Date Considered			<i>6-28-04</i>
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